

Search Notes

Application/Control No.

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Examiner

PHUC H. TRAN

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	229-235 368,371 374,378 381,382	8/24/2005	PT
370	383,395.7	8/24/2005	PT
370	395.71	8/24/2005	PT
370	395.72	8/24/2005	PT
370	412-429	8/24/2005	PT
370	395.1	8/24/2005	PT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	395.1	2/18/2006	PT
370	395.7	6/18/2006	PT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/23/2005	PT
Consulted with Dang Ton	2/15/2006	PT
Text search for interference	2/18/2006	PT